

<b>Notice of References Cited</b>	Application/Control No. 10/817,611		Applicant(s)/Patent Under Reexamination SUN ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0258062	11-2006	Yamazaki et al.	438/149
*	B	US-6,633,831	10-2003	Nikoonahad et al.	702/155
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	K	US-			
	L	US-			
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**NON-PATENT DOCUMENTS**

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